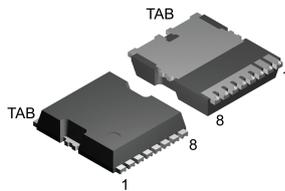
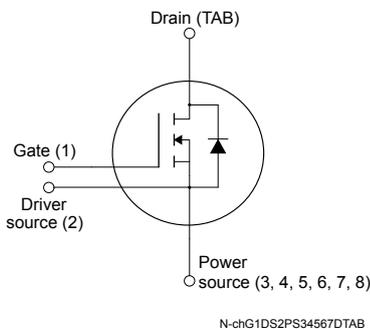


## N-channel 600 V, 23 mΩ typ., 79 A, MDmesh M9 Power MOSFET in a TO-LL package


**TO-LL type A2**

**Product status link**
[STO60N030M9](#)
**Product summary**

<b>Order code</b>	STO60N030M9
<b>Marking</b>	60N030M9
<b>Package</b>	TO-LL type A2
<b>Packing</b>	Tape and reel

### Features

Order code	$V_{DS}$	$R_{DS(on)}$ max.	$I_D$
STO60N030M9	600 V	30 mΩ	79 A

- Very low FOM ( $R_{DS(on)} * Q_g$ )
- Higher  $V_{DSS}$  rating
- Higher dv/dt capability
- Excellent switching performance thanks to the extra driving source pin
- Easy to drive
- 100% avalanche tested

### Application

- AC-DC converters
- DC-DC converters
- Microinverter

### Description

This N-channel Power MOSFET is based on the most innovative super-junction MDmesh M9 technology, suitable for medium/high voltage MOSFETs featuring very low  $R_{DS(on)}$  per area. The silicon based M9 technology benefits from a multi-drain manufacturing process which allows an enhanced device structure. The resulting product has one of the lower on-resistance and reduced gate charge values, among all silicon based fast switching super-junction Power MOSFETs, making it particularly suitable for applications that require superior power density and outstanding efficiency.

# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
V <sub>GS</sub>	Gate-source voltage	±30	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	79	A
	Drain current (continuous) at T <sub>C</sub> = 100 °C	50	
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	340	A
P <sub>TOT</sub>	Total power dissipation at T <sub>C</sub> = 25 °C	255	W
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	50	V/ns
di/dt <sup>(3)</sup>	Peak diode recovery current slope	400	A/μs
dv/dt <sup>(4)</sup>	MOSFET dv/dt ruggedness	120	V/ns
T <sub>stg</sub>	Storage temperature range	-55 to 150	°C
T <sub>J</sub> <sup>(5)</sup>	Operating junction temperature range		°C

1. Referred to TO-247 long leads.
2. Pulse width is limited by safe operating area.
3.  $I_{SD} \leq 40$  A,  $V_{DS}$  (peak) < V<sub>(BR)DSS</sub>, V<sub>DD</sub> = 400 V.
4.  $V_{DS}$  (peak) < V<sub>(BR)DSS</sub>, V<sub>DD</sub> = 400 V.
5. Ambient temperature T<sub>A</sub> ≤ 130 °C.

**Table 2. Thermal data**

Symbol	Parameter	Value	Unit
R <sub>thJC</sub>	Thermal resistance, junction-to-case	0.49	°C/W
R <sub>thJA</sub>	Thermal resistance, junction-to-ambient <sup>(1)</sup>	43	°C/W
	Thermal resistance, junction-to-ambient <sup>(2)</sup>	22	

1. When mounted on a standard 1 inch<sup>2</sup> area of FR-4 PCB with 2-oz copper.
2. When mounted on 40x40 mm area of FR-4 PCB with 2-oz copper.

**Table 3. Avalanche characteristics**

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or non-repetitive (pulse width limited by T <sub>J</sub> max.)	10	A
E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>J</sub> = 25 °C, I <sub>D</sub> = I <sub>AR</sub> , V <sub>DD</sub> = 50 V)	914	mJ

## 2 Electrical characteristics

$T_C = 25\text{ °C}$  unless otherwise specified.

**Table 4. On-/off-states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}$ , $I_D = 1\text{ mA}$	600			V
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0\text{ V}$ , $V_{DS} = 600\text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0\text{ V}$ , $V_{DS} = 600\text{ V}$ , $T_C = 125\text{ °C}^{(1)}$			200	
$I_{GSS}$	Gate-body leakage current	$V_{DS} = 0\text{ V}$ , $V_{GS} = \pm 25\text{ V}$			$\pm 100$	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$	3.2	3.7	4.2	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}$ , $I_D = 40\text{ A}$		23	30	m $\Omega$

1. Specified by design, not tested in production.

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 400\text{ V}$ , $f = 250\text{ kHz}$ , $V_{GS} = 0\text{ V}$	-	6780	-	pF
$C_{oss}$	Output capacitance		-	130	-	pF
$C_{oss\text{ eq.}}^{(1)}$	Equivalent output capacitance	$V_{DS} = 0\text{ to }400\text{ V}$ , $V_{GS} = 0\text{ V}$	-	1300	-	pF
$R_g$	Intrinsic gate resistance	$f = 250\text{ kHz}$ , open drain	-	1.4	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 400\text{ V}$ , $I_D = 40\text{ A}$ , $V_{GS} = 0\text{ to }10\text{ V}$ (see Figure 14. Test circuit for gate charge behavior)	-	140	-	nC
$Q_{gs}$	Gate-source charge		-	38	-	nC
$Q_{gd}$	Gate-drain charge		-	49	-	nC

1.  $C_{oss\text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to stated value.

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 400\text{ V}$ , $I_D = 40\text{ A}$ , $R_G = 4.7\text{ }\Omega$ , $V_{GS} = 10\text{ V}$ (see Figure 13. Switching times test circuit for resistive load and Figure 18. Switching time waveform)	-	35	-	ns
$t_r$	Rise time		-	14	-	ns
$t_{d(off)}$	Turn-off delay time		-	120	-	ns
$t_f$	Fall time		-	5	-	ns

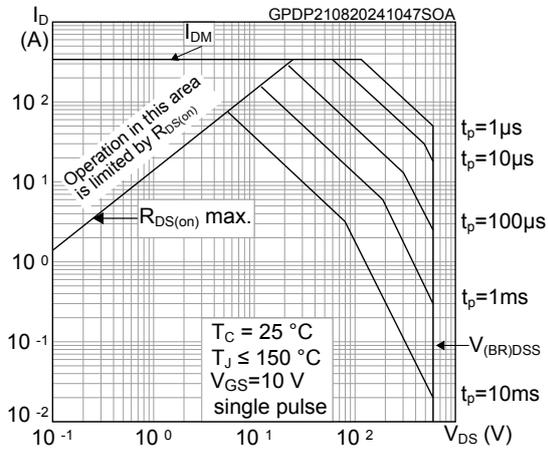
**Table 7. Source-drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}^{(1)}$	Source-drain current		-		79	A
$I_{SDM}^{(2)}$	Source-drain current (pulsed)		-		340	A
$V_{SD}^{(3)}$	Forward on voltage	$I_{SD} = 79\text{ A}$ , $V_{GS} = 0\text{ V}$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 79\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ ,	-	285		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 100\text{ V}$	-	4		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	25		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 79\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ ,	-	398		ns
$Q_{rr}$	Reverse recovery charge	$V_{DD} = 100\text{ V}$ , $T_J = 150\text{ }^\circ\text{C}$	-	7.7		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current	(see Figure 15. Test circuit for inductive load switching and diode recovery times)	-	32		A

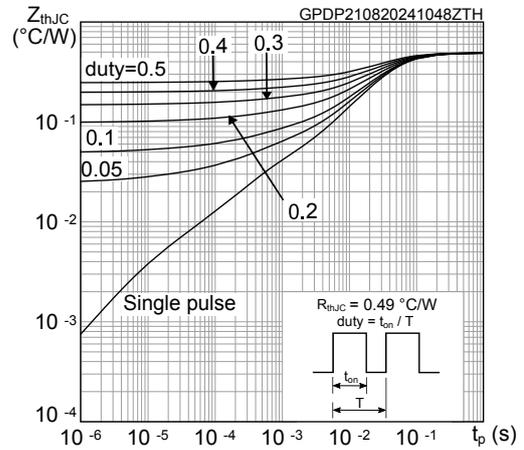
1. Referred to TO-247 long leads.
2. Pulse width is limited by safe operating area.
3. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%.

## 2.1 Electrical characteristics (curves)

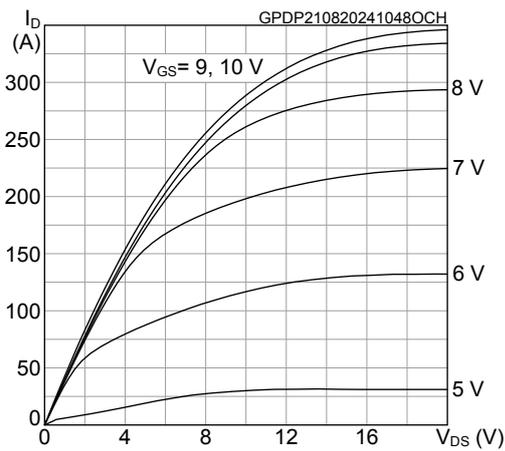
**Figure 1. Safe operating area**



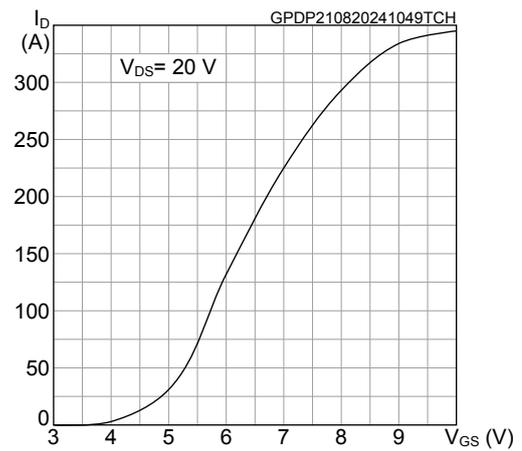
**Figure 2. Maximum transient thermal impedance**



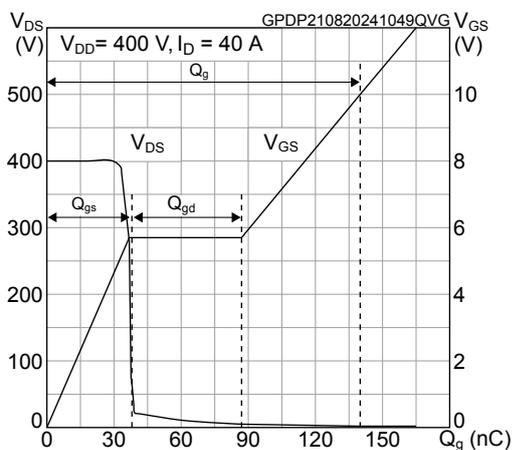
**Figure 3. Typical output characteristics**



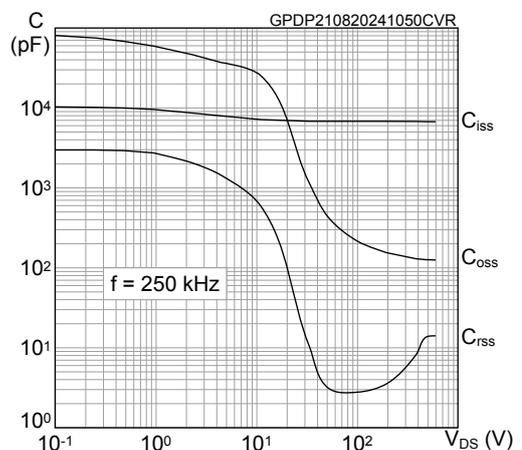
**Figure 4. Typical transfer characteristics**



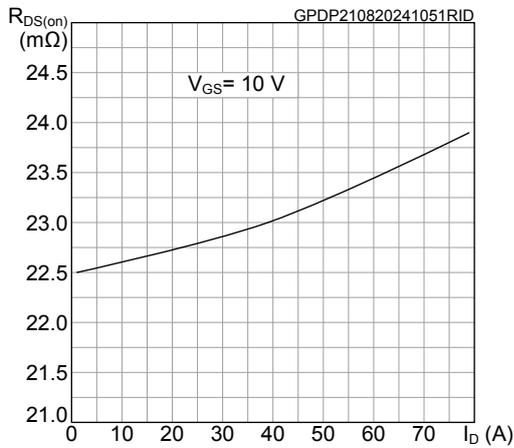
**Figure 5. Typical gate charge characteristics**



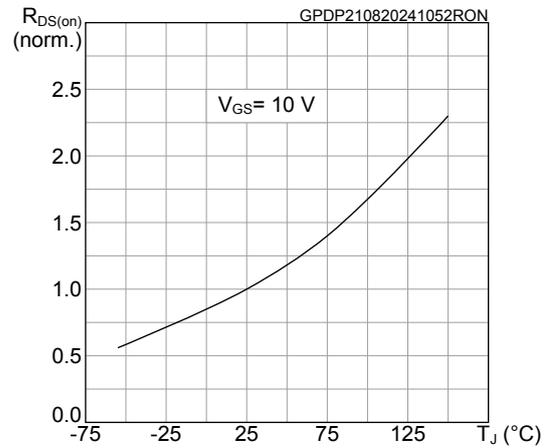
**Figure 6. Typical capacitance characteristics**



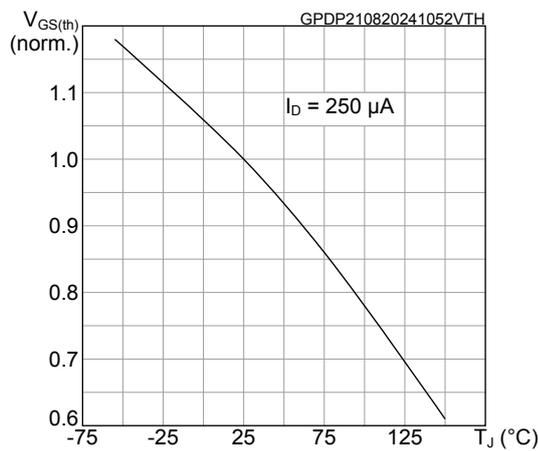
**Figure 7. Typical drain-source on-resistance**



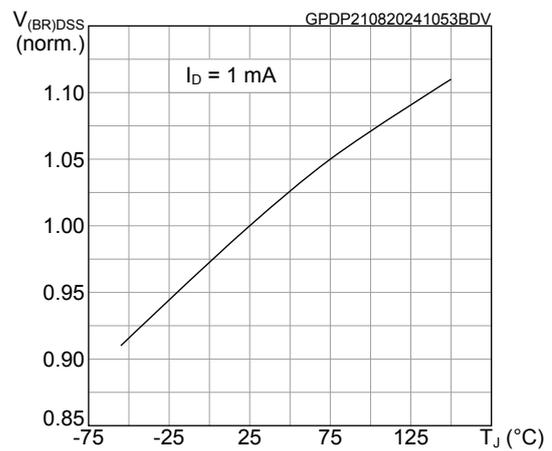
**Figure 8. Normalized on-resistance vs temperature**



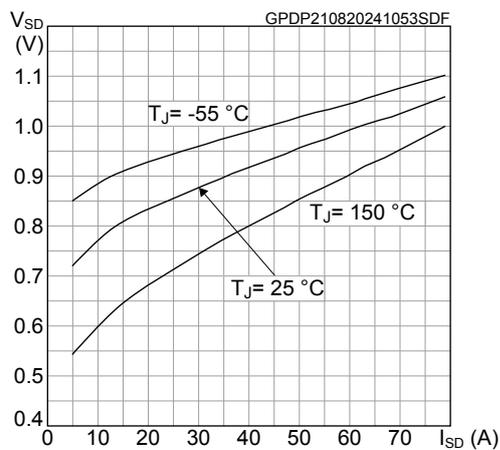
**Figure 9. Normalized gate threshold vs temperature**



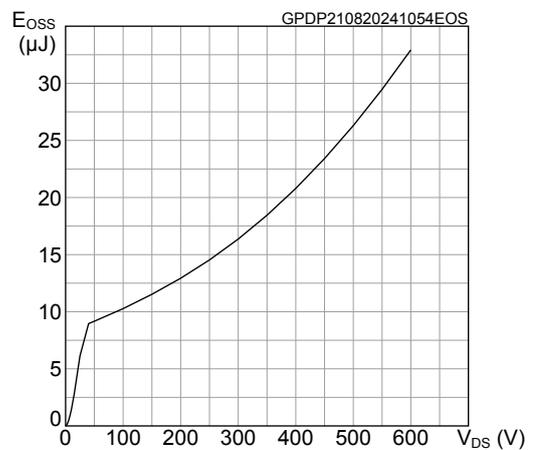
**Figure 10. Normalized breakdown voltage vs temperature**



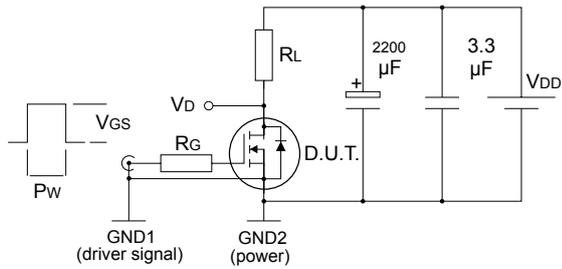
**Figure 11. Typical reverse diode forward characteristics**



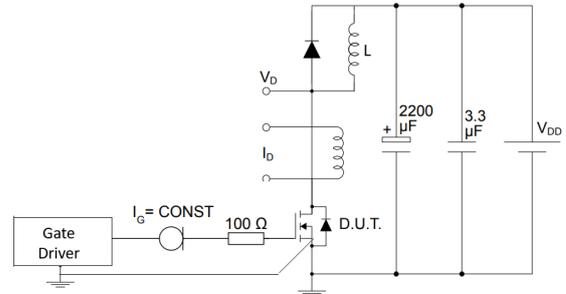
**Figure 12. Typical output capacitance stored energy**



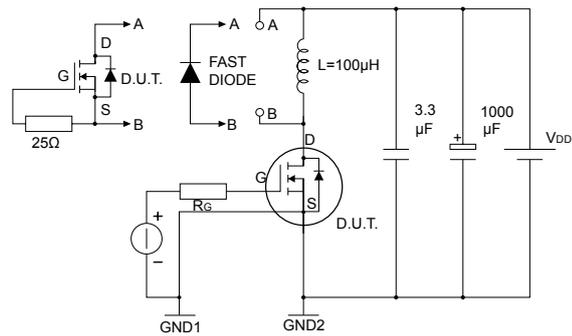
### 3 Test circuits

**Figure 13. Switching times test circuit for resistive load**


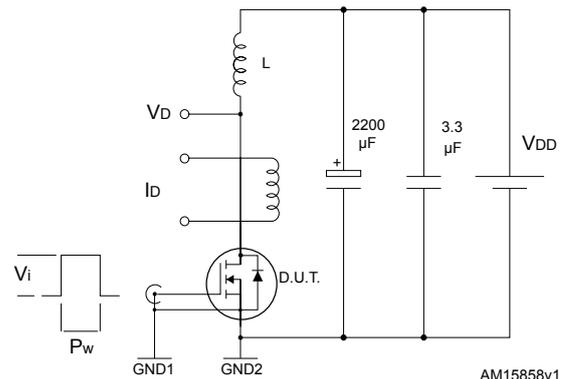
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**Figure 14. Test circuit for gate charge behavior**


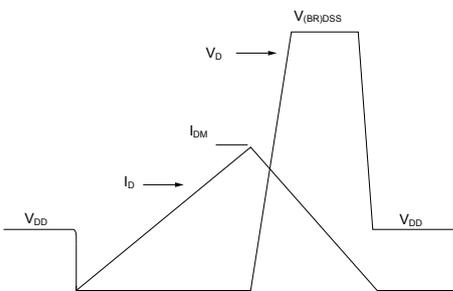
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**Figure 15. Test circuit for inductive load switching and diode recovery times**


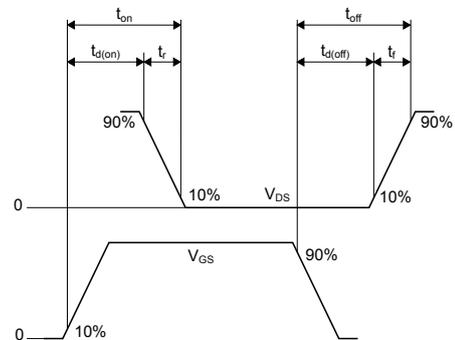
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**Figure 16. Unclamped inductive load test circuit**


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**Figure 17. Unclamped inductive waveform**


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**Figure 18. Switching time waveform**


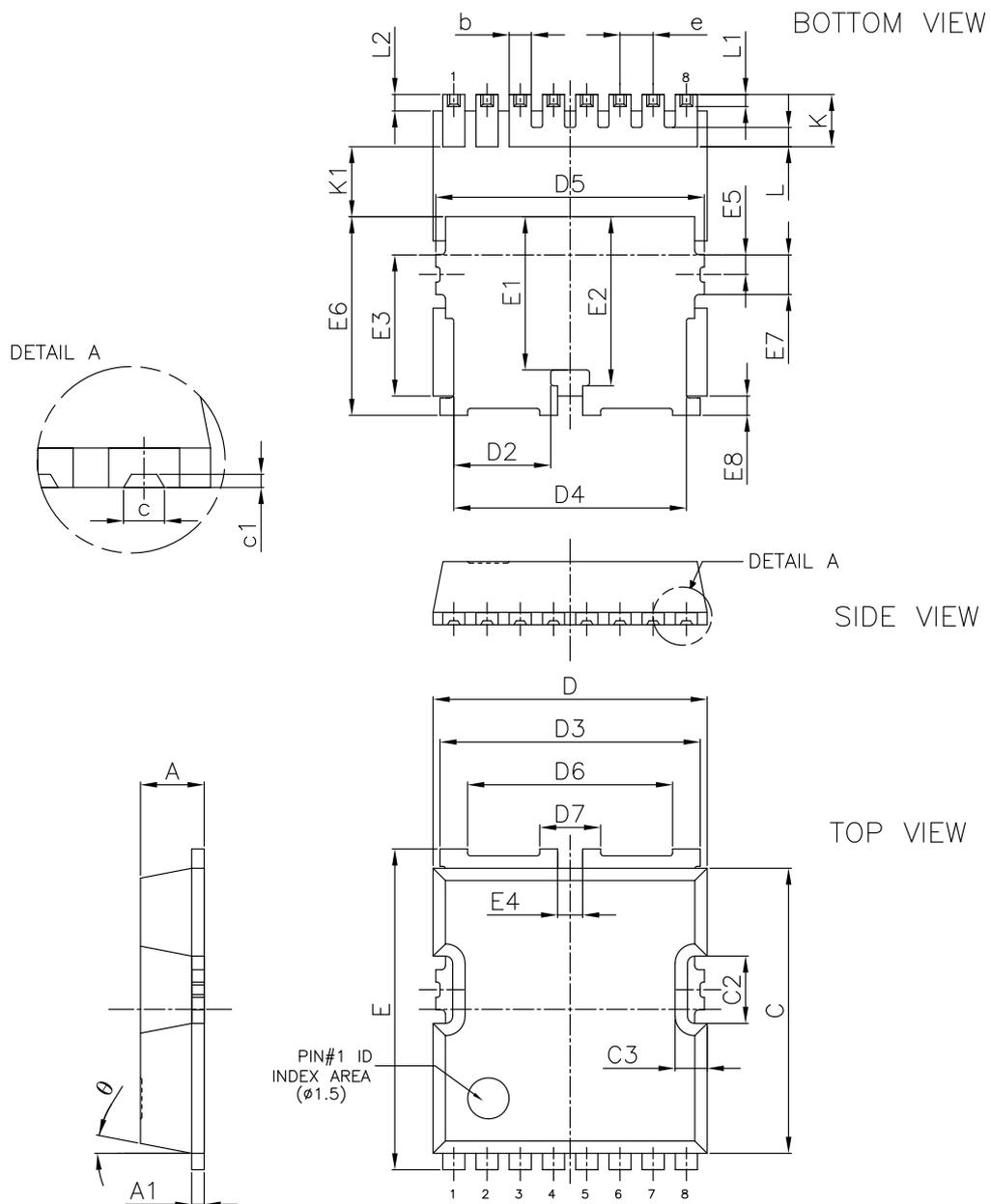
AM01473v1

## 4 Package information

To meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 4.1 TO-LL type A2 package information

Figure 19. TO-LL type A2 package outline

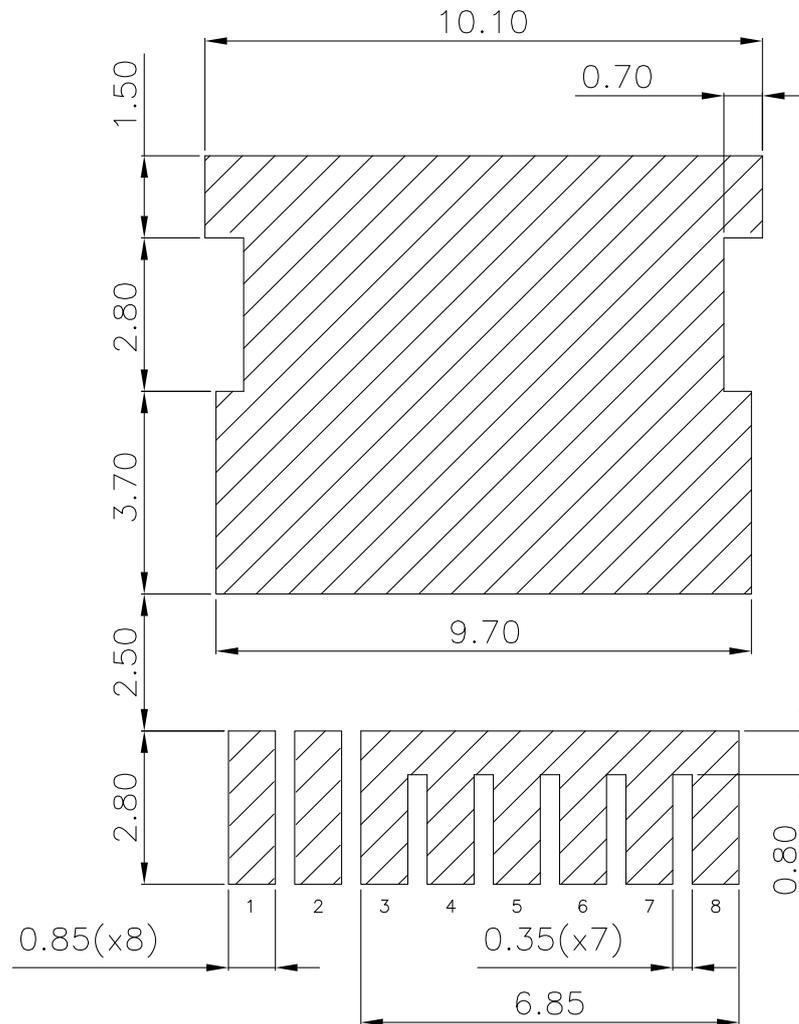


DM00276569\_7\_type\_A2

**Table 8. TO-LL type A2 package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	2.20	2.30	2.40
A1	0.40	0.48	0.60
b	0.70	0.80	0.90
c		0.46	
c1		0.15	
C	10.28	10.38	10.48
C2	2.35	2.45	2.55
C3		1.16	
D	9.80	9.90	10.00
D2	3.30	3.50	3.70
D3	9.30	9.40	9.50
D4	8.20	8.40	8.60
D5	9.50	9.70	9.90
D6		7.40	
D7		2.20	
e		1.20	
E	11.48	11.68	11.88
E1		5.58	
E2		6.15	
E3		5.14	
E4		0.90	
E5		0.72	
E6	7.03	7.23	7.43
E7		1.44	
E8	0.50	0.70	0.90
K	1.70	1.90	2.10
K1	2.40		
L		0.70	
L1		0.44	
L2	0.40	0.60	0.80
θ		11°	

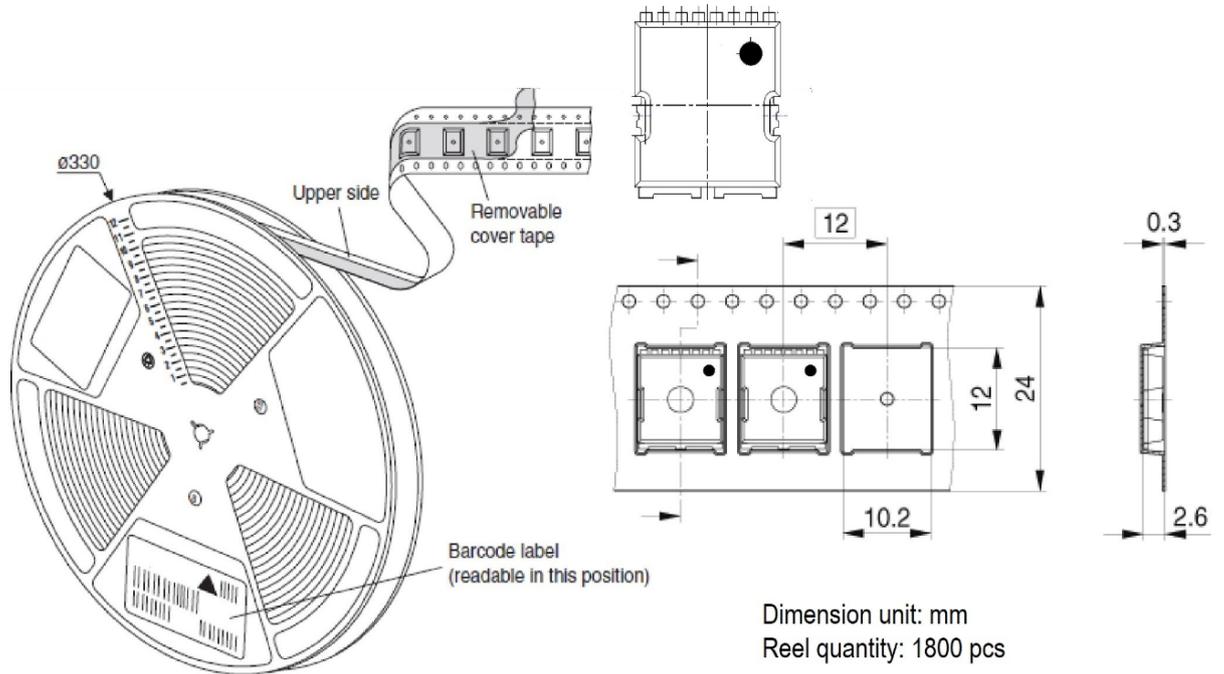
Figure 20. TO-LL type A2 recommended footprint (dimensions are in mm)



DM00276569\_7\_type\_A2



**Figure 23. TO-LL orientation in tape pocket**



## Revision history

**Table 9. Document revision history**

Date	Revision	Changes
27-Aug-2024	1	First release.
25-Oct-2024	2	Updated <i>Features</i> and <i>Application</i> in cover page.
05-Dec-2024	3	Updated <a href="#">Table 1. Absolute maximum ratings</a> , <a href="#">Table 3. Avalanche characteristics</a> and <a href="#">Table 5. Dynamic</a> . Updated <a href="#">Figure 6. Typical capacitance characteristics</a> .

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